

TEST REPORT

APPLICANT : SAMSUNG ELECTRONICS CO., LTD.
ADDRESS : 114, Samseong-ro,
Pyeongtaek-si, Gyeonggi-do, Korea

PAGE: 1 of 9

REPORT NO. RT26R-S0586-003-E1

DATE: Jan. 30, 2026

SAMPLE DESCRIPTION : The following submitted sample(s) said to be:-

NAME/TYPE OF PRODUCT : 12inch wafer (No C/F, No Bump)
NAME OF MATERIAL : Wafer (Patterned)
SAMPLE ID NO. : RT26R-S0586-003
MANUFACTURER/VENDOR : SAMSUNG ELECTRONICS CO., LTD.

SAMPLE RECEIVED : Jan. 21, 2026
TESTING DATE : Jan. 21, 2026 ~ Jan. 30, 2026

TEST METHOD(S) : Please see the following page(s).
TEST RESULT(S) : Please see the following page(s).

* Note 1 : The test results presented in this report refer only to the object tested.

* Note 2 : This report shall not be reproduced except in full without the written approval of the testing laboratory.

Approved by,



Nikkie Lee / Lab. Technical Manager

Authorized by,



Jade Jang / Lab. General Manager



Authenticity check

Intertek Testing Services Korea Ltd.

Office: Tel : 031-8069-3708 Fax : 02-3409-0025 Web Site : intertek.co.kr

Seoul Lab. Address : 7, Ahasan-ro 5-gil, Seongdong-gu, Seoul, 04793 Korea



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TEST REPORT

PAGE: 2 of 9
DATE: Jan. 30, 2026

REPORT NO. RT26R-S0586-003-E1

SAMPLE ID NO. : RT26R-S0586-003
SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)

TEST ITEM	UNIT	TEST METHOD	MDL	RESULT
Cadmium (Cd)	mg/kg	With reference to IEC 62321-5 Edition 1.0 : 2013, by acid digestion and determined by ICP-OES	0.5	N.D.
Lead (Pb)	mg/kg		5	N.D.
Mercury (Hg)	mg/kg	With reference to IEC 62321-4:2013+AMD1:2017 CSV, by acid digestion and determined by ICP-OES	2	N.D.
Hexavalent Chromium (Cr ⁶⁺)	mg/kg	With reference to IEC 62321-7-2 Edition 1.0 : 2017, by alkaline/toluene digestion and determined by UV-VIS Spectrophotometer	8	N.D.
Polybrominated Biphenyl (PBBs)				
Monobromobiphenyl	mg/kg	With reference to IEC 62321-6 Edition 1.0 : 2015, by solvent extraction and determined by GC/MS	5	N.D.
Dibromobiphenyl	mg/kg		5	N.D.
Tribromobiphenyl	mg/kg		5	N.D.
Tetrabromobiphenyl	mg/kg		5	N.D.
Pentabromobiphenyl	mg/kg		5	N.D.
Hexabromobiphenyl	mg/kg		5	N.D.
Heptabromobiphenyl	mg/kg		5	N.D.
Octabromobiphenyl	mg/kg		5	N.D.
Nonabromobiphenyl	mg/kg		5	N.D.
Decabromobiphenyl	mg/kg		5	N.D.
Polybrominated Diphenyl Ether (PBDEs)				
Monobromodiphenyl ether	mg/kg	With reference to IEC 62321-6 Edition 1.0 : 2015, by solvent extraction and determined by GC/MS	5	N.D.
Dibromodiphenyl ether	mg/kg		5	N.D.
Tribromodiphenyl ether	mg/kg		5	N.D.
Tetrabromodiphenyl ether	mg/kg		5	N.D.
Pentabromodiphenyl ether	mg/kg		5	N.D.
Hexabromodiphenyl ether	mg/kg		5	N.D.
Heptabromodiphenyl ether	mg/kg		5	N.D.
Octabromodiphenyl ether	mg/kg		5	N.D.
Nonabromodiphenyl ether	mg/kg		5	N.D.
Decabromodiphenyl ether	mg/kg		5	N.D.

Tested by : Jooyeon Lee, Chano Kim, Hayan Park

Notes : mg/kg = ppm = parts per million
< = Less than
N.D. = Not detected (<MDL)
MDL = Method detection limit

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PAGE: 3 of 9
DATE: Jan. 30, 2026

REPORT NO. RT26R-S0586-003-E1

SAMPLE ID NO. : RT26R-S0586-003

SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)

TEST ITEM	UNIT	TEST METHOD	MDL	RESULT
Bromine (Br)	mg/kg	With reference to EN 14582, by oxygen combustion with bomb and determined by IC	30	N.D.
Chlorine (Cl)	mg/kg	With reference to EN 14582, by oxygen combustion with bomb and determined by IC	30	N.D.
Fluorine (F)	mg/kg	With reference to EN 14582, by oxygen combustion with bomb and determined by IC	30	N.D.
Iodine (I)	mg/kg	With reference to EN 14582, by oxygen combustion with bomb and determined by IC	30	N.D.
Arsenic (As)	mg/kg	With reference to US EPA 3052, by acid digestion and determined by ICP-OES	2	N.D.
Beryllium (Be)	mg/kg	With reference to US EPA 3052, by acid digestion and determined by ICP-OES	2	N.D.
Phosphorus (P)	mg/kg	With reference to US EPA 3052, by acid digestion and determined by ICP-OES	2	N.D.
Antimony (Sb)	mg/kg	With reference to US EPA 3052, by acid digestion and determined by ICP-OES	2	N.D.
Polyvinyl chloride (PVC)	-	With reference to KS K 0210-1, and determined by FT-IR	N.A.	Negative

Tested by : Chano Kim, Jooyeon Lee

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 N.A. = Not applicable
 Negative = Undetectable
 Positive = Detectable

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TEST REPORT

PAGE: 4 of 9
DATE: Jan. 30, 2026

REPORT NO. RT26R-S0586-003-E1

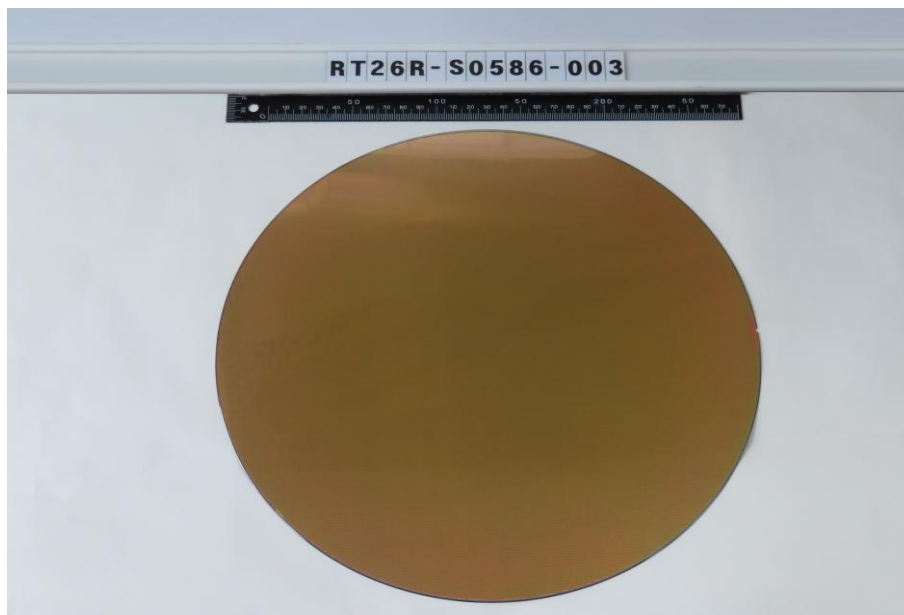
SAMPLE ID NO. : RT26R-S0586-003
SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)

TEST ITEM	CAS NO.	UNIT	TEST METHOD	MDL	RESULT
Dibutyl phthalate (DBP)	84-74-2	mg/kg	With reference to IEC 62321-8 Edition 1.0 : 2017, by solvent extraction and determined by GC/MS	50	N.D.
Di(2-ethylhexyl) phthalate (DEHP)	117-81-7	mg/kg		50	N.D.
Benzyl butyl phthalate (BBP)	85-68-7	mg/kg		50	N.D.
Diisobutyl phthalate (DIBP)	84-69-5	mg/kg		50	N.D.

Tested by : Hayan Park

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* View of sample as received;-



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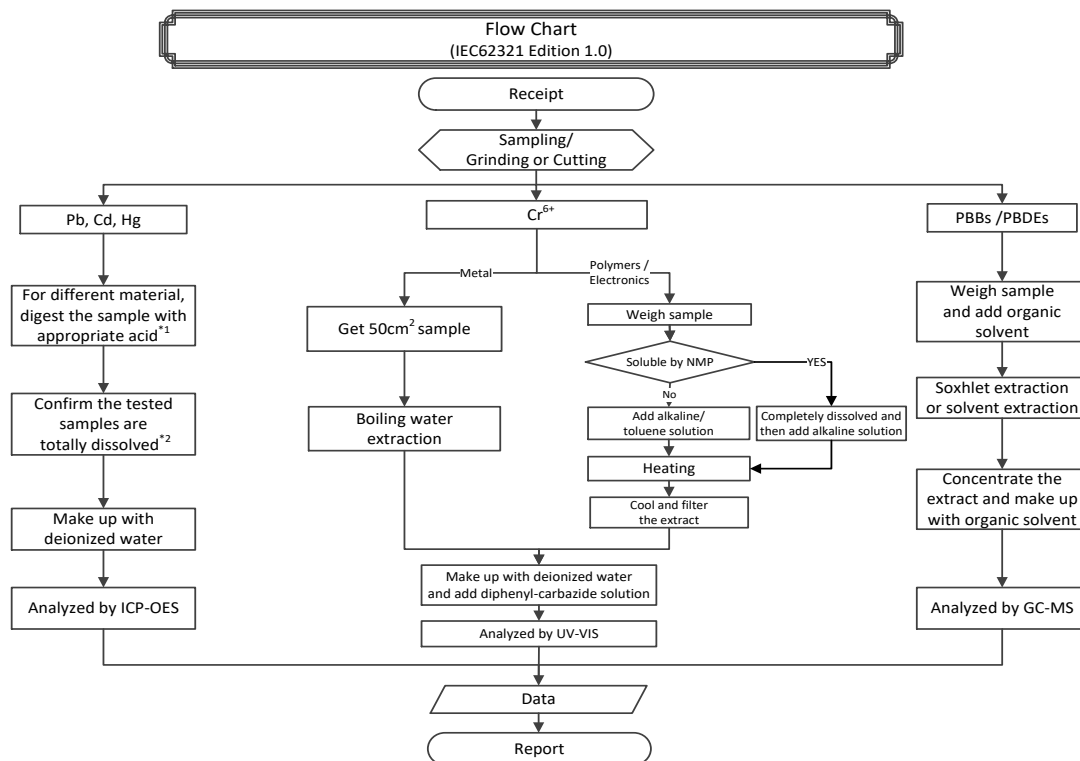
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TEST REPORT

PAGE: 5 of 9
DATE: Jan. 30, 2026

REPORT NO. RT26R-S0586-003-E1

SAMPLE ID NO. : RT26R-S0586-003
SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)



Remarks :

*1 : List of appropriate acid :

Material	Acid added for digestion
Polymers	HNO ₃ , HCl, HF, H ₂ O ₂ , H ₃ BO ₃
Metals	HNO ₃ , HCl, HF
Electronics	HNO ₃ , HCl, H ₂ O ₂ , HBF ₄

*2 : The samples were dissolved totally by pre-conditioning method according to above flow chart.

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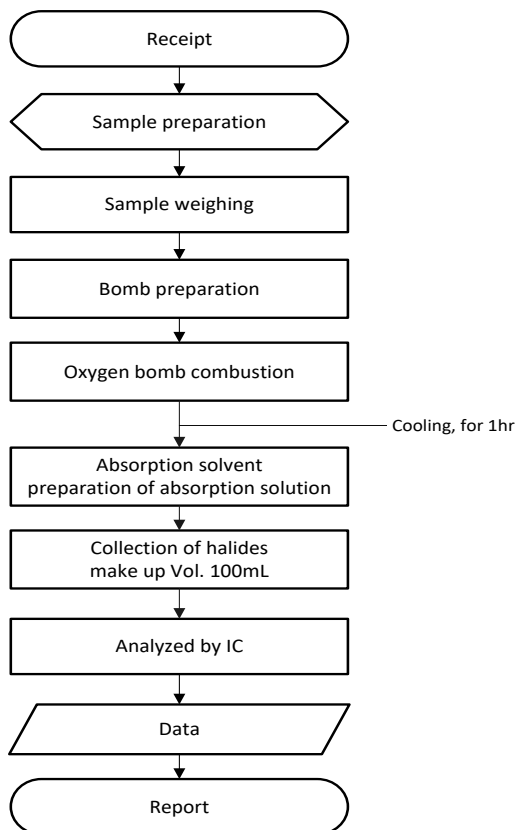
PAGE: 6 of 9
DATE: Jan. 30, 2026

REPORT NO. RT26R-S0586-003-E1

SAMPLE ID NO. : RT26R-S0586-003

SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)

Flow Chart (EN14582)



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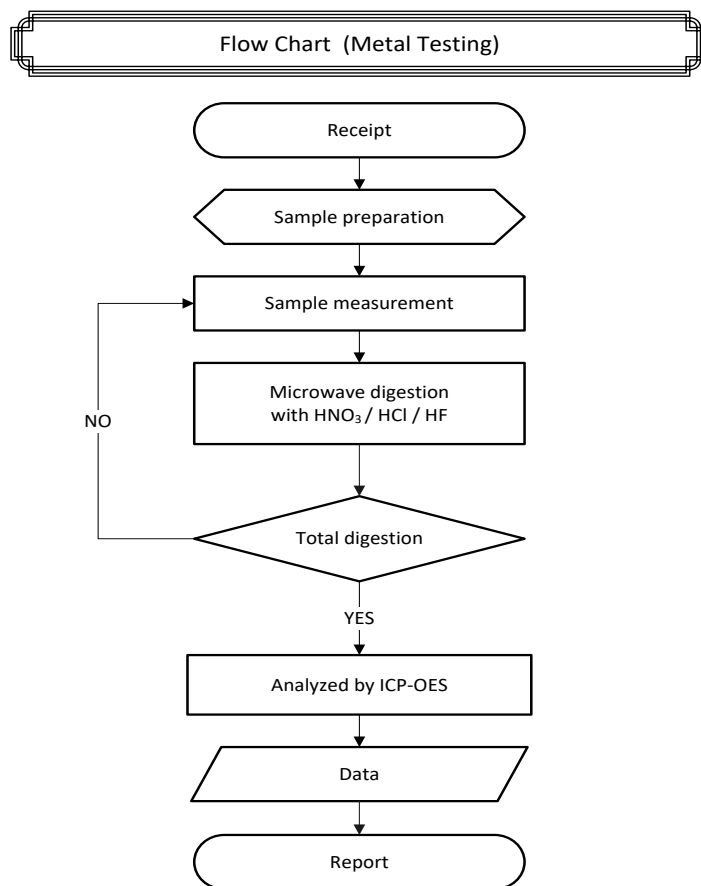
TEST REPORT

PAGE: 7 of 9
DATE: Jan. 30, 2026

REPORT NO. RT26R-S0586-003-E1

SAMPLE ID NO. : RT26R-S0586-003

SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)



** Remarks : The samples were dissolved totally by pre-conditioning method according to above flow chart.

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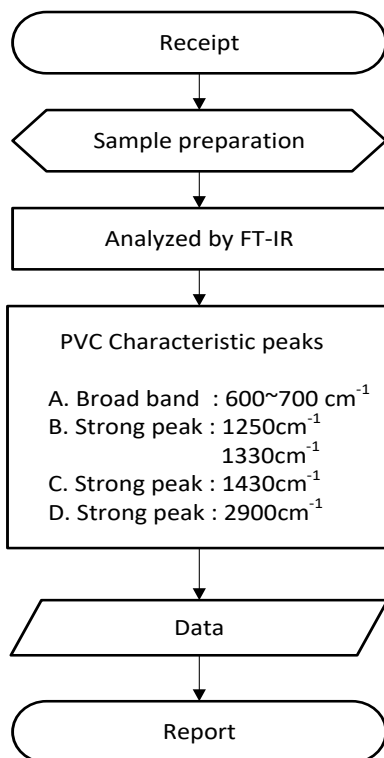
PAGE: 8 of 9
DATE: Jan. 30, 2026

REPORT NO. RT26R-S0586-003-E1

SAMPLE ID NO. : RT26R-S0586-003

SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)

Flow Chart (PVC)



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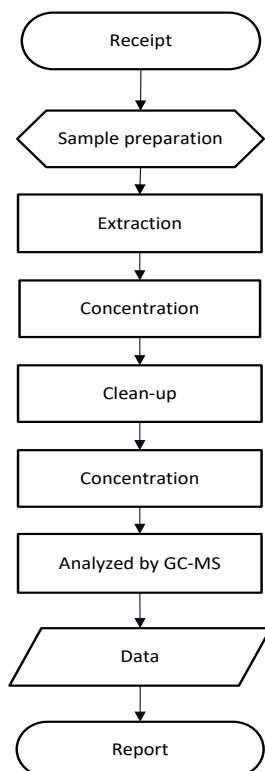
TEST REPORT

REPORT NO. RT26R-S0586-003-E1

PAGE: 9 of 9
DATE: Jan. 30, 2026

SAMPLE ID NO. : RT26R-S0586-003
SAMPLE DESCRIPTION : 12inch wafer (No C/F, No Bump)

Flow Chart (Phthalates)



***** End of Report *****

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